





IrNDT -

Systems for Non-Destructive Testing with Active Thermography

- Contactless quality control
- Fast, large-area scans
- Modular architecture enables performing lock-in, pulse, transient and vibro thermography measurements, as well as TSA
- Supports a wide variety of excitation sources, e.g. halogen lamps, flash lamps, laser, ultrasound, eddy current, among others.
- Presets of inspection parameters for the analysis of the most common materials

Non-destructive testing with IrNDT

IrNDT is a modular solution for non-destructive testing that supports all known NDT techniques based on active thermography:

- → Lock-in thermography
- Pulse thermography
- Transient thermography
- → Vibro thermography
- → Thermal stress analysis

Depending on the inspection task, the IrNDT base package is complemented with one or more evaluation modules. This way the system can be customized to meet the customer needs; containing only the tools required to solve the application.

(> cost effective compact solution)

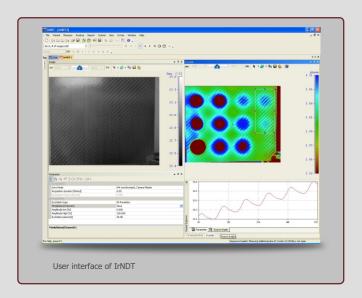
The measuring principle

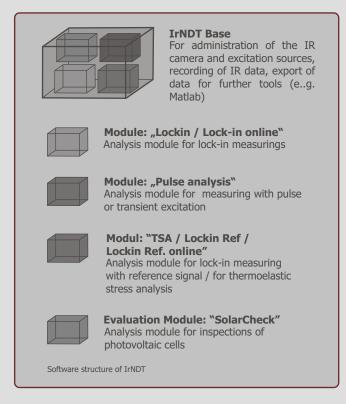
A heat source gives the inspected material a thermal excitation. The flow of thermal energy through the material has a direct influence on the temperature development on the object's surface. If the temperature development on the surface is recorded over a certain period of time with an infrared camera and a mathematical analysis is applied to the acquired data. Then, if the processed data is displayed as an image, this image will provide us with information about the internal structure of the material or about possible defects in it.

By applying different measuring procedures, the inspection can be optimally adapted to the material or defect searched. The different inspection methods differ from each other particularly from the type of excitation source used, the way the thermal excitation is applied and the type of mathematical analysis used.

Data base Connection

- → Data base with client-server-architecture for administration of result images, measuring parameters, reporting, etc. (incl. sorting and search functions)
- → The data base includes powerful image-processing functions, such as image subtraction, image comparison, image stitching, transparent mode, automated resizing of images, report generator for Word and PowerPoint, among others features.







Main Features of IrNDT at a glance



Non-destructive inspection of materials



Modular architecture that enables easy upgrading of system solutions without problems



Very flexible measuring and evaluation algorithms for application-specific inspections



Graphical user interface for easy set-up of inspection parameters



Integrated script-engine for the creation of Macros for solving complex inspection processes



Integrated COM/DCOM automation interface for control and data exchange

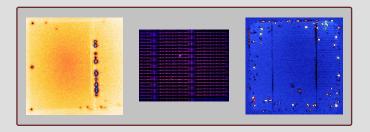


Presets of Parameters for the inspection of the most common materials

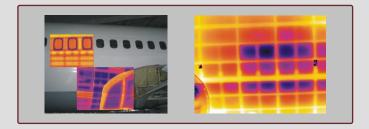
Inspection examples

| | Lock-in | Lock-in | Pulse/T | ransient | TSA | Inspection task |
|---------------------------------|----------|---------|----------|----------|----------|--|
| | Online | | Short | Long | | |
| Halogen lamps/ IR emitter | / | 1 | _ | V | - | - Composite materials (dispondings, delaminations, etc.) - Foamed materials (cavities, etc.) - Leather (defects, etc.) |
| Flash lamps | - | - | V | - | - | - Metal (welded seams corrosion, etc.) - Composite materials (dispondings, delaminations, etc.) |
| Ultrasound | V | / | _ | V | - | - Detection of cracks and delaminations |
| Laser | / | 1 | V | / | - | - Inspections where high-precision energy excitation is required (e.g. For small components) |
| Eddy current | / | / | _ | V | - | - Metal (cracks, etc.) |
| Mechanical excitation | - | - | _ | _ | Y | - Thermal stress analysis (TSA) |

Solutions for Specific NDT Applications

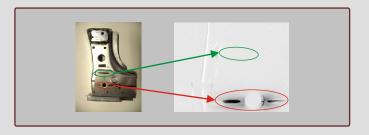












SolarCheck

SolarCheck was designed for the quality assurance of solar cells. The system serves for the detection of shunts and/or micro cracks, as well as for determination of the life expectancy of charge-carriers. SolarCheck supports the inspection techniques ILIT, DLIT, photo- and electroluminescence.

DashboardCheck

DashboardCheck is a system solution for the quality assurance of dashboards and other foamed parts. The system is ideal for contact-free detection of air cavities and other manufacturing defects within the foam material. The DashboardCheck system is available in the Online and Offline versions.

JetCheck

The JetCheck system was designed for the quality assurance of aircrafts. Its main advantage is that it can cover large areas per measurement, making it ideal for the inspection of an airplanes' hull, wings, rudders, etc. The system can be used for the detection of delaminations, disbondings, water inclusions, previous repair works, among others.

CrackCheck

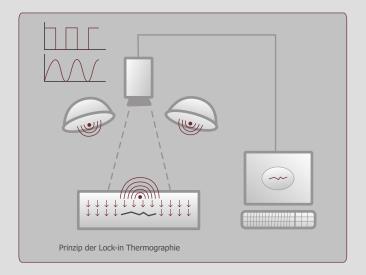
CrackCheck is a solution for crack detection using ultrasound energy as excitation. It applies the methods of lock-in and pulse thermography for its analysis and can help detect even small defects within the material independently of their geometrical orientation. It is an ideal system for quality assurance after repair works.

CompositeCheck

The NDT solution for the quality assurance of composite materials such as Carbon Reinforced Plastic (CRP) and Glass Reinforced Plastic (GRP), among others. The system can be acquired in its compact presentation to serve as a mobile inspection system, ideal for the detection of disbondings, delaminations, etc.

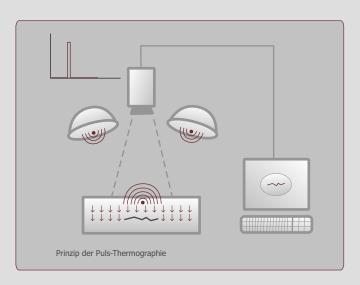
WeldCheck

WeldCheck is a system solution for the nondestructive inspection of welded joints. It's very short inspection times (<1 Sec.), and the fact that the measurements are performed free of contact makes this system ideal for its integration into production lines for online quality inspection.



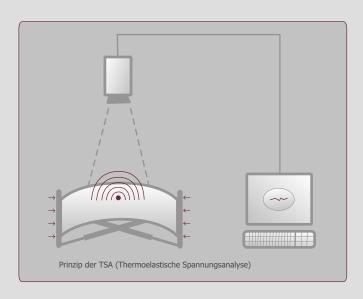
Lock-in thermography

The principle of the lock-in thermography is based on creating a thermal wave on the surface of a object and analyze its' penetration into the material. As the thermal wave penetrates into the object, if it reaches a defect (e.g. at delaminations or inclusions), it gets partly reflected. The reflected part interferes with the wave entering at the surface, whereby an interference pattern in the local surface temperature and thus in the surface radiation is caused. The mathematical analysis of this pattern will provide us information about the internal structure of test object.



Pulse thermography

The principle of pulse thermography is the stimulation of the surface by a signal of heat which uniformly penetrates into the material. If the thermal front should reach an area with a defect, it gets blocked, causing an increase of temperature in the object's surface. If this thermal behavior is recorded by an infrared camera, and a mathematical analysis is applied to the acquired date, then we can obtain depth-resolved information about the structure of the material. This technique works very good for large-areas scans, and requires in general shorter inspection times (when compared to the lock-in technique).



TSA

The thermo-elastic effect generates changes in the temperature of an object when stressed mechanically. The Thermal Stress Analysis (TSA) uses this effect, recording and evaluating these slight changes in the temperature. The resulting images show the different levels of tension in different colors, making it very easy to determine the areas that suffer more mechanical stress. This is therefore a great method for studying material fatigue and for optimizing the design of the new components and parts.

IrNDT -

Technical Specifications

| Infrared cameras | | | | |
|---|---|--|--|--|
| Supported cameras | - FLIR Systems SC-Series (SC7000, SC6000, SC5000, SC4000, SC3000, SC2000, SC325, SC305, SC660, SC620, SC325, SC305), - FLIR Systems A-Series (A615, A315,A310, A300) - IRSmartEye640, IRSmartEye320 - Omega, Phoenix, Merlin, Agema900, CEDIP, etc. | | | |
| Camera interfaces | Gigabit Ethernet, Firewire (IEEE1394), IRFlashLink | | | |
| PC | Gigabit Ethernet, Filewire (IEEE1394), IKi lasiiLilik | | | |
| PC types | Industry PCs, Laptops (for mobile systems) | | | |
| Supported operating systems | Windows 7, Vista, XP, W2000, NT4 | | | |
| Excitation sources | | | | |
| Light (Halogen lamps, Infrared emitter) | 1kW - 33kW | | | |
| Flash lamps | 6kJ - 24kJ | | | |
| Ultrasound | Adjustment of frequency from 15 kHz to 25 kHz, Adjustment of amplitude from 0 to 100% | | | |
| Laser | High-precision laser with 400µm fiber optic interface, Power 32W, wave length 808nm | | | |
| Eddy current | DC (max. power 3,0kW), output frequency control: 8 - 30kHz | | | |
| Mechanical excitation | | | | |
| Software | | | | |
| | lline, pulse/transient, TSA, photovoltaic cell inspection | | | |
| · · · · · · · · · · · · · · · · · · · | sy creation of customer specific solutions without programming skills | | | |
| | up of inspection reports, export of inspection data to MatLab, storing of storing of result images including its measuring parameters | | | |
| Integrated script-engine for the creation | of Macros for solving complex inspection processes | | | |
| → Integrated COM/DCOM automation interf | face for control and data exchange | | | |
| Measuring and Analysis properties | | | | |
| Parameters for the excitation source | → Analysis functions: pulse, sinus, trapezium, rectangle, user defined function → Rectangle width at rectangle modulation: 0,1% - 99,9% → Excitation frequency: 1µHz -50 kHz | | | |
| Parameters for the IR camera (depending on camera type) | Recording frequency, integration time, temperature range, average temperature, detector window, etc. | | | |
| · · · · · · · · · · · · · · · · · · · | Analysis methods: Several Methods for analysis of lock-in, pulse and transient thermography Special functions for the inspection of photovoltaic cells (analysis module SolarCheck) Special functions for thermal stress analysis (analysis module TSA) Automatic noise reduction functions and compensation of exterior interferences in all analysis modules | | | |

→ Saving of all properties in workspaces



Administration of properties

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